

High voltage, high current Darlington transistor array

BA12001B / BA12002 / BA12003B / BA12003BF / BA12004B

The BA12001B, BA12002, BA12003B, BA12003BF, and BA12004B are high current transistor arrays featuring high voltage withstand resistance and consisting of seven circuits of Darlington transistors. Because it incorporates built-in surge-absorbing diodes and base current-control resistors needed when using inductive loads such as relay coils, attachments can be kept to a minimum. With an output withstanding voltage as high as 60V (BA12001B, BA12003B, BA12003BF, and BA12004B) and an output current (sink current) of 500mA, this product is ideal for use with various drivers and as an interface with other elements.

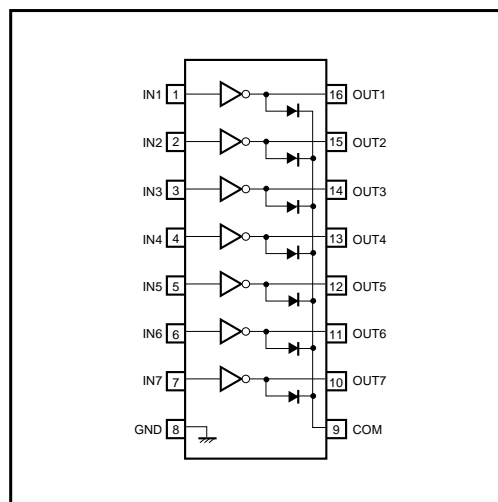
●Applications

Drivers for LEDs, lamps, relays and solenoids
Interface with other elements

●Features

- 1) High output current. ($I_{OUT} = 500\text{mA Max.}$)
- 2) High output voltage withstand resistance. ($V_{OUT} = 50\text{V Max.}$)
- 3) Seven Darlington transistors built in.
- 4) Equipped with output surge-absorbing clamp diode. (Note: Refer to the "Reference items when using in application.")

●Block diagram



●Internal circuit configuration

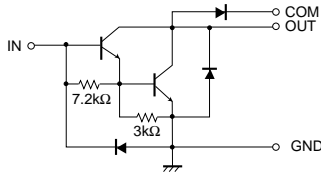


Fig.1 BA12001B

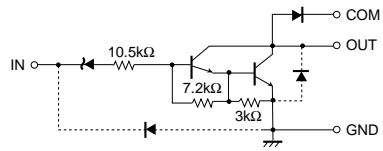


Fig.2 BA12002

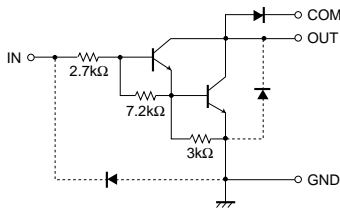


Fig.3 BA12003B / BF

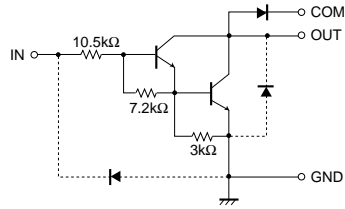


Fig.4 BA12004B

●Absolute maximum ratings (Ta = 25°C)

Parameter		Symbol	Limits	Unit
Power supply voltage	other than BA12002	V _{CE}	60	V
	BA12002		50	
Input voltage	other than BA12001B	V _{IN}	- 0.5 ~ + 30	V
Input current	BA12001B	I _{IN}	25	mA / driver
Output current		I _{OUT}	500	mA / driver
Ground pin current		I _{GND}	2.3*1	A
Power dissipation	DIP package	P _d	1250*2	mW
	SOP package		625*3	
Diode reverse voltage		V _R	60	V
Diode forward current		I _F	500	mA
Operating temperature		T _{opr}	- 25 ~ + 75	°C
Storage temperature		T _{stg}	- 55 ~ + 150	°C

*1 Pulse width ≦ 20ms, duty cycle ≦ 10%, same current for all 7 circuits

*2 Reduced by 10mW for each increase in Ta of 1°C over 25°C .

*3 Reduced by 50mW for each increase in Ta of 1°C over 25°C .

●Recommended operating conditions (Ta = 25°C)

Parameter		Symbol	Min.	Typ.	Max.	Unit	Conditions
Output current		I _{OUT}	—	—	350	mA	Fig.9, 10
Power supply voltage	Other than BA12002	V _{CE}	—	—	55	V	—
	BA12002		—	—	50		—
Input voltage (excluding BA12001B)		V _{IN}	—	—	30	V	—
Input current (BA12001B only)		I _{IN}	—	—	25	mA / driver	—

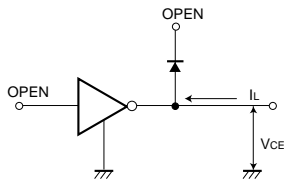
●Electrical characteristics (unless otherwise noted, Ta=25°C)

Parameter		Symbol	Min.	Typ.	Max.	Unit	Conditions
Output leakage current		I _L	—	0	10	μA	V _{CE} = 60V (only BA12002: V _{CE} = 50V)
DC current transfer ratio		h _{FE}	1000	2400	—	V	V _{CE} = 2V, I _{OUT} = 350mA
Output saturation voltage		V _{CE(sat)}	—	0.94	1.1	V	I _{OUT} = 100mA, I _{IN} = 250μA
				1.14	1.3		I _{OUT} = 200mA, I _{IN} = 350μA
				1.46	1.6		I _{OUT} = 350mA, I _{IN} = 500μA
Input voltage	BA12002	V _{IN}	—	10.2	11	V	V _{CE} = 2V, I _{OUT} = 100mA
	BA12003B / BF			1.75	2		
	BA12004B			2.53	5		
	BA12002	V _{IN}	—	10.4	12	V	V _{CE} = 2V, I _{OUT} = 200mA
	BA12003B / BF			1.91	2.4		
	BA12004B			2.75	6		
BA12002	V _{IN}	—	10.7	13.5	V	V _{CE} = 2V, I _{OUT} = 350mA	
BA12003B / BF			2.17	3.4			
BA12004B			3.27	8			
Input current	BA12002	I _{IN}	—	0.88	1.3	mA	V _{IN} = 17V
	BA12003B / BF			0.90	1.35		V _{IN} = 3.85V
	BA12004B			0.39	0.5		V _{IN} = 5V
Diode reverse current		I _R	—	0	50	μA	V _R = 60V (only BA12002: V _R = 50V)
Diode forward voltage		V _F	—	1.73	2	V	I _F = 350mA
Input capacitance		C _{IN}	—	30	—	pF	V _{IN} = 0V, f = 1MHz

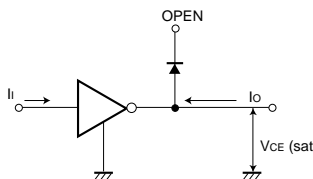
Note: Input voltage and input current for BA12001 vary based on external resistor.

●Measurement circuits

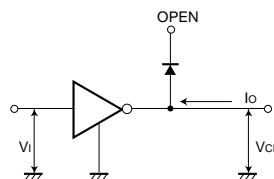
(1) Output leakage current I_L



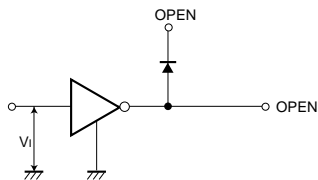
(2) DC current transfer ratio $h_{FE} = \frac{I_o}{I_i}$
Output saturation voltage $V_{CE(sat)}$



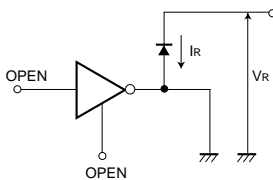
(3) Input voltage V_{IN}



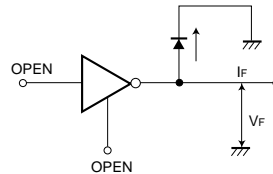
(4) Input current I_{IN}



(5) Diode reverse current I_R



(6) Diode forward voltage I_F



(7) Input capacitance C_{IN}

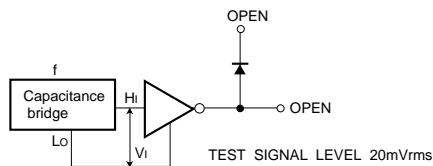


Fig.5

●Application example

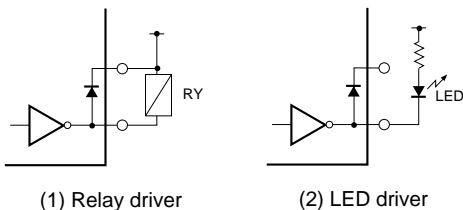


Fig.6

●Reference items when using in application

The BA12001B is a transistor array which can be directly coupled to a general logic circuit such as PMOS, CMOS, or TTL.

Because the base current is limited to 25mA, a current limiting resistor needs to be connected in series with the input.

The BA12002 is designed for direct coupling with a 14 to 25V system PMOS. In order to limit the input current, a level shift diode (7V) and resistor are connected in series to each of the inputs.

The BA12003B / BF can be coupled directly to TTL or CMOS output (when operating at 5V). In order to limit the input current to a stable value, resistors are connected in series to each of the inputs.

The BA12004B is designed for direct coupling to CMOS or PMOS output using a 6 to 15V power supply voltage. In order to limit the input current to a stable value, resistors are connected in series to each of the inputs.

The load for each of these products should be connected between the driver output and the power supply. To protect the IC from excessive swing voltage, the COM pin (Pin 9) should be connected to the power supply.

Fig. 7 shows the configuration of the on-chip diode for surge absorption.

In the construction of the surge-absorbing diode, there is an N-P junction between the N-layer (N-well + BL) and the substrate (P-sub) so that when the diode is on, current flows from the output pin to the substrate. In terms of the vertical construction, this diode is configured similar to a PNP transistor. When using the surge-absorbing diode, take appropriate measures regarding

the thermal characteristics of the design considering the current that will be handled.

Also, if motor back-rush current or other conditions that will result continued surge current to flow to the surge-absorbing diode can be foreseen, we strongly recommend connecting a Schottky barrier diode (or other type of diode with a low forward voltage) in parallel with the surge-absorbing diode to construct a bypass route for the surge current.

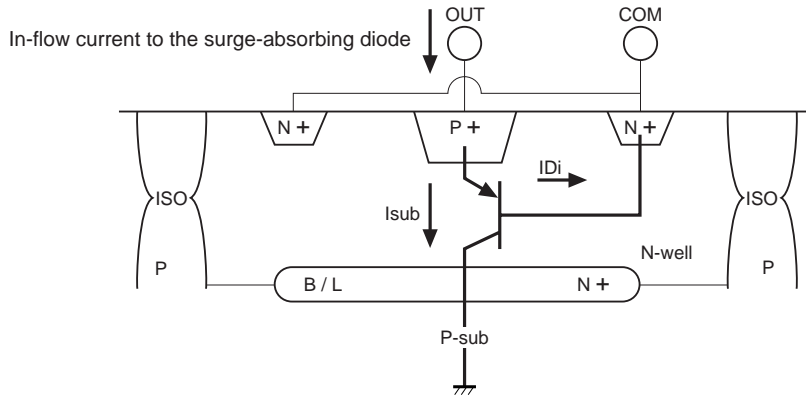


Fig. 7 Vertical construction of the surge-absorbing diode

● Electrical characteristic curves

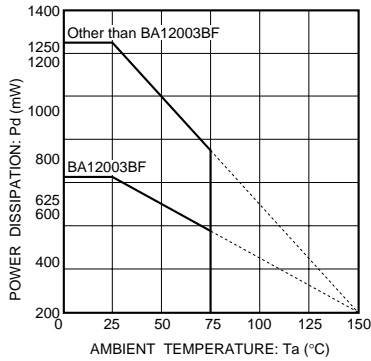


Fig. 8 Power dissipation vs. ambient temperature



Fig. 9 Output conditions (I)

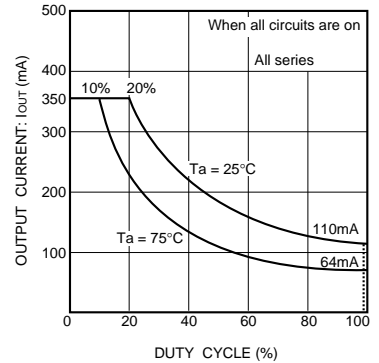


Fig. 10 Output conditions (II)

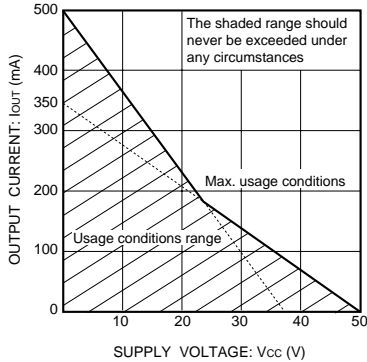


Fig. 11 Usage conditions range per circuit

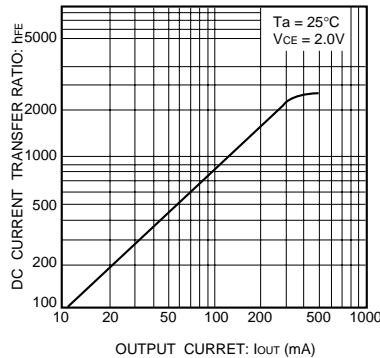


Fig. 12 DC current transfer ratio vs. output current

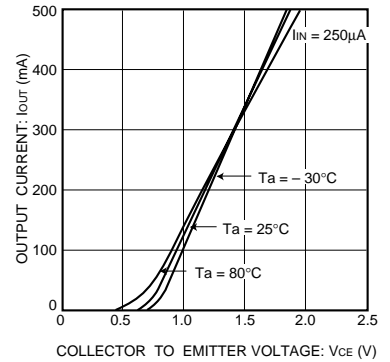


Fig. 13 Output current vs. voltage between collector and emitter

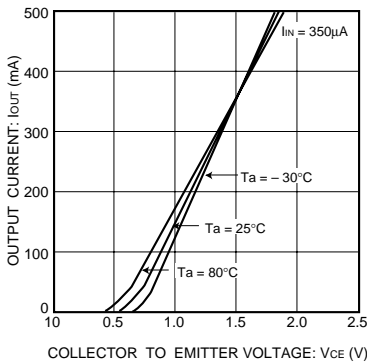


Fig. 14 Output current vs. voltage between collector and emitter

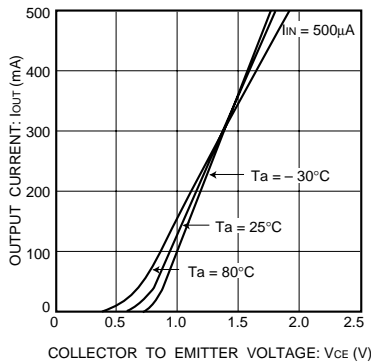


Fig. 15 Output current vs. voltage between collector and emitter

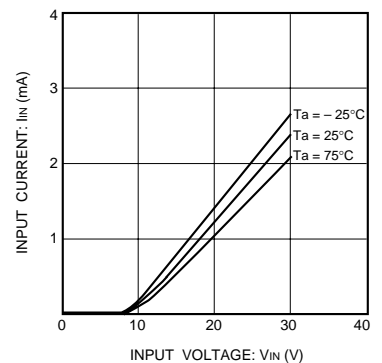


Fig. 16 Input current vs. input voltage (BA12002)

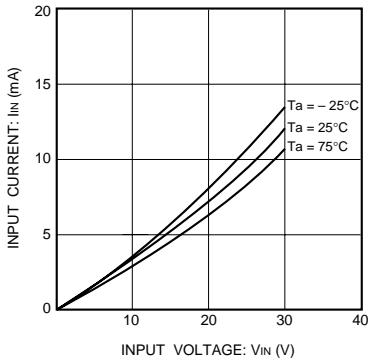


Fig. 17 Input current vs. input voltage (BA12003B / BF)

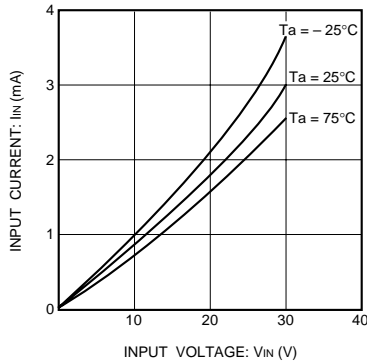


Fig. 18 Input current vs. input voltage (BA12004B)

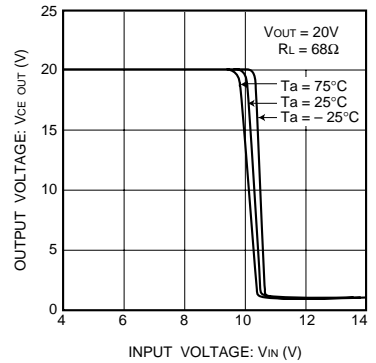


Fig. 19 Output voltage vs. input voltage (BA12002)

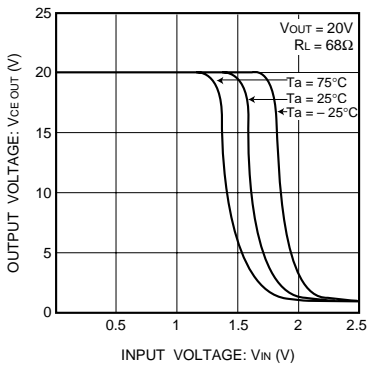


Fig. 20 Output voltage vs. input voltage (BA12003B / BF)

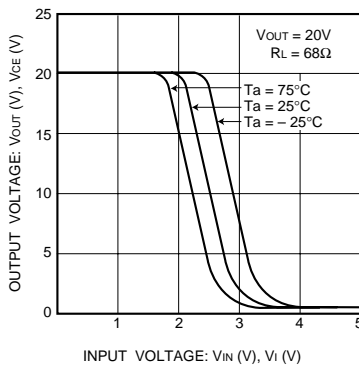


Fig. 21 Output voltage vs. input voltage (BA12004B)

● External dimensions (Units: mm)

